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Samsung Electro-Mechanics America, Inc. CL10CR56BB8NNNC

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Distributor of Samsung Electro-Mechanics America, Inc.: Excellent Integrated System Lin

Datasheet of CL10CR56BB8NNNC - CAP CER 0.56PF 50V NP0 0603







SPECIFICATION

• Supplier : Samsung electro-mechanics • Samsung P/N : CL10CR56BB8NNNC

• Product : Multi-layer Ceramic Capacitor • Description : CAP, 0.56pF, 50V, ±0.1pF, C0G, 0603

A. Samsung Part Number

<u>CL</u> <u>10</u> <u>C</u> <u>R56</u> <u>B</u> <u>B</u> <u>8</u> <u>N</u> <u>N</u> <u>N</u> <u>O</u> <u>C</u> ① ② ③ ④ ⑤ ⑥ ⑦ ⑧ ⑨ ⑩ ⑪

| 1 | Series | Samsung Multi-layer Ceramic Capacitor | | | | | | | |
|---|---------------|---------------------------------------|----------|-----|----------|---------|----|---------------|--------------|
| 2 | Size | 0603 (inch o | code) L: | 1.6 | ± 0.1 | mm | W: | 0.8 ± 0.1 | mm |
| | | | | | | | | | |
| 3 | Dielectric | C0G | | 8 | Inner el | ectrode | | Ni | |
| 4 | Capacitance | 0.56 pF | | | Termina | ation | | Cu | |
| ⑤ | Capacitance | ±0.1 pF | | | Plating | | | Sn 100% | (Pb Free) |
| | tolerance | | | 9 | Produc | t | | Normal | |
| 6 | Rated Voltage | 50 V | | 10 | Special | | | Reserved for | future use |
| 7 | Thickness | 0.8 ± 0.1 | mm | 11) | Packag | ing | | Cardboard Ty | ype, 7" reel |

B. Samsung Reliablility Test and Judgement condition

| | Performance | Test condition | | | | | |
|-------------------|--|---------------------------------------|--|--|--|--|--|
| Capacitance | Within specified tolerance | 1Mb±10% 0.5~5Vrms | | | | | |
| Q | 411.2 min | | | | | | |
| Insulation | 10,000Mohm or 500Mohm⋅μF | Rated Voltage 60~120 sec. | | | | | |
| Resistance | Whichever is Smaller | | | | | | |
| Appearance | No abnormal exterior appearance | Microscope (×10) | | | | | |
| Withstanding | No dielectric breakdown or | 300% of the rated voltage | | | | | |
| Voltage | mechanical breakdown | | | | | | |
| Temperature | COG | | | | | | |
| Characterisitcs | (From -55 $^{\circ}\!$ | | | | | | |
| Adhesive Strength | No peeling shall be occur on the | 500g·F, for 10±1 sec. | | | | | |
| of Termination | terminal electrode | | | | | | |
| Bending Strength | Capacitance change : | Bending to the limit (1mm) | | | | | |
| | within ±5% or ±0.5pF whichever is larger | with 1.0mm/sec. | | | | | |
| Solderability | More than 75% of terminal surface | SnAg3.0Cu0.5 solder | | | | | |
| | is to be soldered newly | 245±5℃, 3±0.3sec. | | | | | |
| | | (preheating : 80~120 ℃ for 10~30sec.) | | | | | |
| Resistance to | Capacitance change : | Solder pot : 270±5℃, 10±1sec. | | | | | |
| Soldering heat | within ±2.5% or ±0.25pF whichever is larger | | | | | | |
| | Tan δ, IR : initial spec. | | | | | | |



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| | Performance | Test condition | | | | |
|---------------------------|---|-------------------------------------|--|--|--|--|
| Vibration Test | Capacitance change : | Amplitude : 1.5mm | | | | |
| | within ±2.5% or ±0.25pF whichever is larger | From 10Hz to 55Hz (return : 1min.) | | | | |
| | Tan δ, IR : initial spec. | 2hours × 3 direction (x, y, z) | | | | |
| Moisture | Capacitance change : | With rated voltage | | | | |
| Resistance | within ±7.5% or ±0.75pF whichever is larger | 40±2℃, 90~95%RH, 500+12/-0hrs | | | | |
| | Q: 101.87 min | | | | | |
| | IR: 500Mohm or 25Mohm $\cdot \mu$ F | | | | | |
| | Whichever is Smaller | | | | | |
| High Temperature | Capacitance change : | With 200% of the rated voltage | | | | |
| Resistance | within ±3% or ±0.3pF whichever is larger | Max. operating temperature | | | | |
| | Q: 205.6 min | 1000+48/-0hrs | | | | |
| | IR : 1000Mohm or 50Mohm · μΓ | | | | | |
| | Whichever is Smaller | | | | | |
| Temperature | Capacitance change : | 1 cycle condition | | | | |
| Cycling | within ±2.5% or ±0.25pF whichever is larger | Min. operating temperatur → 25 °C | | | | |
| Tan δ, IR : initial spec. | | → Max. operating temperature → 25°C | | | | |
| | | | | | | |
| | | | | | | |
| | | 5 cycle test | | | | |

C. Recommended Soldering method:

^{*} For the more detail Specification, Please refer to the Samsung MLCC catalogue.